

74ABT126 Quad Buffer with 3-STATE Outputs

Features

- Non-inverting buffers
- Output sink capability of 64mA, source capability of 32mA
- Guaranteed latchup protection
- High impedance glitch free bus loading during entire power up and power down cycle
- Nondestructive hot insertion capability
- Disable time less than enable time to avoid bus contention

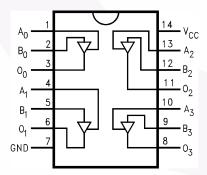
Ordering Information

Order NumberPackage
NumberPackage Description74ABT126CSCM14A14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150"
Narrow74ABT126CSJM14D14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide74ABT126CMTCMTC1414-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153,
4.4mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagram



Pin Description

Pin Names	Description
A _n , B _n	Inputs
O _n	Outputs

General Description

The ABT126 contains four independent non-inverting buffers with 3-STATE outputs.

Function Table

Inp	outs	Output
An	B _n	O _n
Н	L	L
Н	Н	Н
L	Х	Z

H = HIGH Voltage Level

L = LOW Voltage Level

Z = HIGH Impedance

X = Immaterial

January 2008

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
T _{STG}	Storage Temperature	–65°C to +150°C
T _A	Ambient Temperature Under Bias	–55°C to +125°C
TJ	Junction Temperature Under Bias	–55°C to +150°C
V _{CC}	V _{CC} Pin Potential to Ground Pin	-0.5V to +7.0V
V _{IN}	Input Voltage ⁽¹⁾	-0.5V to +7.0V
I _{IN}	Input Current ⁽¹⁾	-30mA to +5.0mA
V _O	Voltage Applied to Any Output	
	Disabled or Power-Off State	-0.5V to 5.5V
	HIGH State	–0.5V to V_{CC}
	Current Applied to Output in LOW State (Max.)	twice the rated I _{OL} (mA)
	DC Latchup Source Current (Across Comm Operating Range)	–300mA
	Over Voltage Latchup (I/O)	10V

Note:

1. Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
T _A	Free Air Ambient Temperature	–40°C to +85°C
V _{CC}	Supply Voltage	+4.5V to +5.5V
$\Delta V / \Delta t$	Minimum Input Edge Rate	
	Data Input	50mV/ns
	Enable Input	100mV/ns

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Symbol	Р	arameter	V _{cc}	Conditions	Min.	Тур.	Max.	Units
V _{IH}	Input HIGH	Voltage		Recognized HIGH Signal	2.0			V
V _{IL}	Input LOW	Voltage		Recognized LOW Signal			0.8	V
V _{CD}	Input Clam	p Diode Voltage	Min.	I _{IN} = -18mA			-1.2	V
V _{OH}	Output HIG	H Voltage	Min.	$I_{OH} = -3mA$	2.5			V
				$I_{OH} = -32mA$	2.0			
V _{OL}	Output LOV	V Voltage	Min.	$I_{OL} = 64 \text{mA}$			0.55	V
I _{IH}	Input HIGH	Current	Max.	$V_{IN} = 2.7 V^{(2)}$			1	1 µA
				$V_{IN} = V_{CC}$			1	
I _{BVI}	BVI Input HIGH Current Breakdown Test		Max.	V _{IN} = 7.0V			7	μA
I _{IL} Input LOW Current		Max.	$V_{IN} = 0.5V^{(2)}$			_1 μA		
			$V_{IN} = 0.0V$			-1	1	
V _{ID}	D Input Leakage Test		0.0	I _{ID} = 1.9μA, All Other Pins Grounded	4.75			V
I _{OZH}	Output Leakage Current		0-5.5V	$V_{OUT} = 2.7V, \overline{OE}_n = 2.0V$			10	μA
I _{OZL}	Output Leakage Current		0-5.5V	$V_{OUT} = 0.5V, \overline{OE}_n = 2.0V$			-10	μA
I _{OS}	Output Short-Circuit Current		Max.	$V_{OUT} = 0.0V$	-100		-275	mA
I _{CEX}	Output HIGH Leakage Current		Max.	$V_{OUT} = V_{CC}$			50	μA
I _{ZZ}	Bus Draina	ge Test	0.0	V _{OUT} = 5.5V, All Others GND			100	μA
I _{CCH}	Power Sup	oly Current	Max.	All Outputs HIGH			50	μA
I _{CCL}	Power Sup	oly Current	Max.	All Outputs LOW			15	mA
I _{CCZ}	Power Supply Current		Max.	$\overline{OE}_n = V_{CC}$, All Others at V_{CC} or Ground			50	μA
I _{CCT}	I _{CCT} Additional Outputs Enabled		Max.	$V_{I} = V_{CC} - 2.1V$			1.5	mA
I _{CC} /Input	Outputs 3-STATE		Enable Input $V_I = V_{CC} - 2.1V$			1.5	mA	
		Outputs 3-STATE		Data Input $V_I = V_{CC} - 2.1V$, All Others at V_{CC} or Ground			50	μA
I _{CCD}	CCD Dynamic I _{CC} No Load ⁽²⁾		Max.	Outputs OPEN, $\overline{OE}_n = GND^{(3)}$, One-Bit Toggling, 50% Duty Cycle			0.1	mA/ MHz

Notes:

2. Guaranteed, but not tested.

3. For 8-bit toggling, $I_{CCD} < 0.8 mA/MHz.$

AC Electrical Characteristics

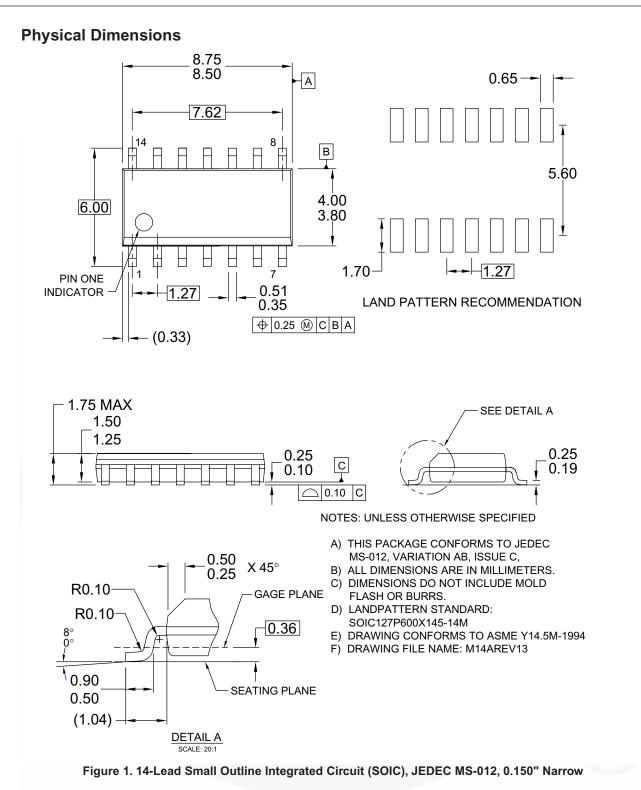
		T _A = +25°C, V _{CC} = +5V, C _L = 50pF		$ \begin{array}{c} T_{A} = -40^{\circ}C \ to \ +85^{\circ}C \\ V_{CC} = 4.5V - 5.5V \\ C_{L} = 50 pF \end{array} $			
Symbol	Parameter	Min.	Тур.	Max.	Min.	Max.	Units
t _{PLH}	Propagation Delay, Data to Outputs	1.0		4.4	1.0	4.4	ns
t _{PHL}		1.0		4.6	1.0	4.6	
t _{PZH}	Output Enable Time	1.0		6.5	1.0	6.5	ns
t _{PZL}		1.0		6.5	1.0	6.5	
t _{PHZ}	Output Disable Time	1.0		5.8	1.0	5.8	ns
t _{PLZ}		1.0		5.5	1.0	5.5	

Capacitance

Symbol	Parameter	Conditions T _A = 25°C	Тур.	Units
C _{IN}	Input Capacitance	$V_{CC} = 0V$	5.0	pF
C _{OUT} ⁽⁴⁾	Output Capacitance	$V_{CC} = 5.0V$	9.0	pF

Note:

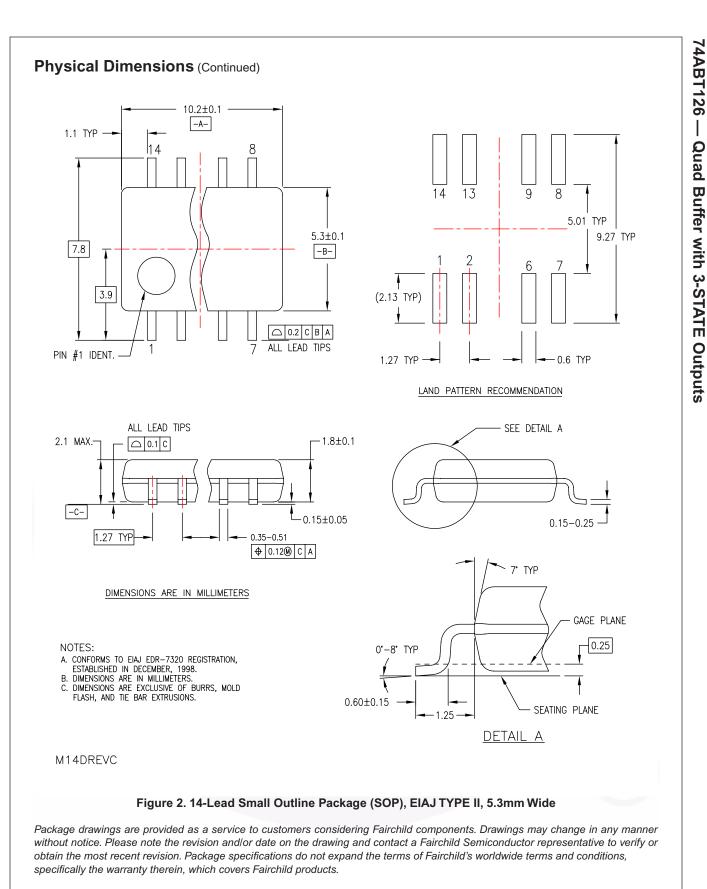
4. C_{OUT} is measured at frequency f = 1MHz, per MIL-STD-883, Method 3012.



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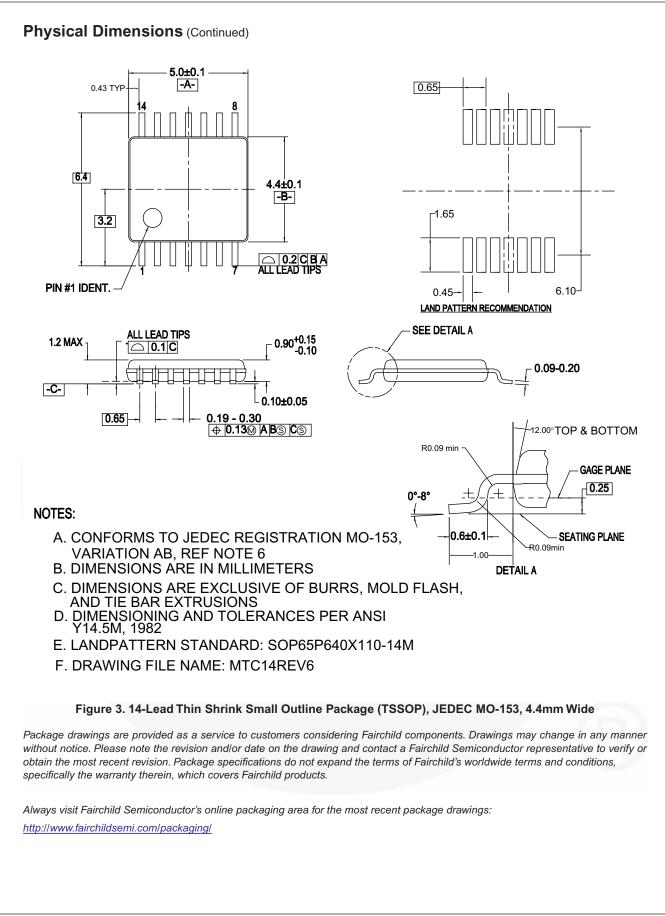
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